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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/815,024	03/31/2004	Raoul J. Belleau	T0529.70016US00	9189
75	90 12/12/2005		EXAM	INER
Edmund J. Walsh			KOBERT, RUSSELL MARC	
Wolf, Greenfield & Sacks, P.C. 600 Atlantic Avenue			ART UNIT	PAPER NUMBER
Boston, MA 02210			2829	

DATE MAILED: 12/12/2005

Please find below and/or attached an Office communication concerning this application or proceeding.

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	Application No.	Applicant(s)	
0.65	10/815,024	BELLEAU, RAOUL J.	
Office Action Summary	Examiner	Art Unit	
	Russell M. Kobert	2829	
The MAILING DATE of this communication app Period for Reply	ears on the cover sheet with th	e correspondence address	
A SHORTENED STATUTORY PERIOD FOR REPLY WHICHEVER IS LONGER, FROM THE MAILING DA - Extensions of time may be available under the provisions of 37 CFR 1.13 after SIX (6) MONTHS from the mailing date of this communication. - If NO period for reply is specified above, the maximum statutory period v - Failure to reply within the set or extended period for reply will, by statute, Any reply received by the Office later than three months after the mailing earned patent term adjustment. See 37 CFR 1.704(b).	ATE OF THIS COMMUNICATE 36(a). In no event, however, may a reply be will apply and will expire SIX (6) MONTHS for cause the application to become ABANDO	ON. e timely filed rom the mailing date of this communication. DNED (35 U.S.C. § 133).	
Status			
 1) ☐ Responsive to communication(s) filed on 03 No. 2a) ☐ This action is FINAL. 2b) ☐ This 3) ☐ Since this application is in condition for allower closed in accordance with the practice under Exercise. 	action is non-final.		
Disposition of Claims			
4) ☐ Claim(s) 1-24 is/are pending in the application. 4a) Of the above claim(s) is/are withdray 5) ☐ Claim(s) is/are allowed. 6) ☐ Claim(s) 1-10 and 18 is/are rejected. 7) ☐ Claim(s) 11-17 and 19-24 is/are objected to. 8) ☐ Claim(s) are subject to restriction and/o	wn from consideration.		
Application Papers			
9) The specification is objected to by the Examine 10) The drawing(s) filed on is/are: a) accomplicant may not request that any objection to the Replacement drawing sheet(s) including the correct 11) The oath or declaration is objected to by the Examine	epted or b) objected to by the drawing(s) be held in abeyance. ion is required if the drawing(s) is	See 37 CFR 1.85(a). objected to. See 37 CFR 1.121(d).	
Priority under 35 U.S.C. § 119			
 12) Acknowledgment is made of a claim for foreign a) All b) Some * c) None of: 1. Certified copies of the priority document 2. Certified copies of the priority document 3. Copies of the certified copies of the priority document * See the attached detailed Office action for a list 	s have been received. s have been received in Applic rity documents have been rece u (PCT Rule 17.2(a)).	cation No eived in this National Stage	
Attachment(s)			
1) Notice of References Cited (PTO-892)	4) Interview Summ Paper No(s)/Ma		
 Notice of Draftsperson's Patent Drawing Review (PTO-948) Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08) Paper No(s)/Mail Date <u>0604</u>. 	_	al Patent Application (PTO-152)	

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1. Applicant's election of Invention I in the reply filed on 3 November 2005 is

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acknowledged. Because applicant did not distinctly and specifically point out the

supposed errors in the restriction requirement, the election has been treated as an

election without traverse (MPEP § 818.03(a)).

2. Applicant's amendment to claims 19 and 22 to be dependent on elected method

claim 1 is hereby acknowledged and Applicant's admission that all claims in the

application are therefore within the elected invention is further acknowledged; there

being no other claims pending to other inventions in the instant application.

3. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that

form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

(b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United

States.

4. Claims 1-2 and 18 are rejected under 35 U.S.C. 102(b) as being anticipated by

Leonida (5367200).

Leonida anticipates a method of measuring duty cycle of an interval of a signal,

comprising the acts:

providing as an input signal repetitions of the interval of the signal (signal 30 and col 2,

In 66-68);

making a plurality of comparisons of the value of the input signal to a threshold at controlled times relative to the start of a repetition of the interval, making the plurality of comparisons including varying the controlled time (using the discussed ramp generator and Voltage Controlled Oscillator (VCO) as the clock input to flip-flop 34; see also col 3, ln 2-5, 30-40); and

computing a duty cycle, based on the number of comparisons having a value in a predetermined range relative to the threshold (col 3, ln 8-30); as recited in claim 1.

As to claim 2, having the signal being a digital clock and the interval being a positive integer multiple of the period of the clock is anticipated by Leonida (col 2, ln 53-55).

As to claim 18, having the controlled times controlled so that the plurality of comparisons are made at times relative to the start of a repetition of the interval that are uniformly distributed over the duration of the interval is anticipated by Leonida (in the embodiment of Figure 6, Leonida discusses the use of a control 76 that is dependent on instruction from a CPU 70 that determines this instruction based on multiple input signals IN1 to Inx (col 3, In 67 - col 4, In 29)).

5. Claims 3-10 are rejected under 35 U.S.C. 103(a) as being unpatentable over Leonida (5367200) as applied to claim 1 above, and further in view of Bowhers et al (4792932).

Although Leonida does not show the signal being a differential signal, Bowhers et al shows the measurement of differential signals (col 3, ln 21-24) as described in claim 3.

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Although Leonida does not show the method being performed using automatic test equipment, Bowhers et al discusses in its entirety the use of automatic test equipment for making time measurements including duty cycle as described in claim 6.

It would have been obvious to one having ordinary skill in the art at the time the invention was made to have combined the teaching of Bowhers et al with the teaching of Leonida to make the claimed invention because each utilizes test methods for determining duty cycles in digital electronic systems and to automate the control of such an apparatus, using automatic test equipment and the such, permits less user intervention and more control of operations such as recording and displaying data for improved analysis and calibration of clock timers. Moreover, the limitations of claims 4, 5 and 7-10 are considered to be within the normal range of operating the apparatus of the above combination.

6. The following is a statement of reasons for the indication of allowable subject matter:

Claims 11-17 and 19-24 are objected to as being dependent upon a rejected base claim, but would be allowable if rewritten in independent form including all of the limitations of the base claim and any intervening claims.

The added limitation of making a plurality of comparisons comprises running a test pattern a plurality of times and varying the controlled time further comprises varying the controlled time between runs of the test pattern as further detailed in claim 11 has not been found.

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The added limitation of having the automatic test equipment used in the process of making semiconductor devices to measure the duty cycle of a signal produced by semiconductor devices being manufactured and the computed duty cycle being further used to alter the process of making the semiconductor devices as further described in claim 14 has not been found.

The added limitations of the automatic test equipment comprising failure processing circuitry having the act comprising running a pattern with the timing generator programmed to produce strobe signals with a first time relationship to the input signal, the pattern programming the expect value of the comparator to be a value indicating that the input signal is in a first logical state; and at the end of the pattern, recording the count of comparisons made by the failure processing circuitry indicating that the value at the input of the comparator deviates from the expected value; and iteratively altering the programming of the timing generator to produce strobe signals with a different time relationship to the input signal, rerunning the pattern and recording the count of comparisons indicating that the value at the input of the comparator deviates from the expected value made by the failure processing circuitry as further described in claim 19 has not been found.

It is further noted that the examiner's reasons are understood to be predicated upon consideration of each of the claims as a whole, and not upon any specific elements of the claims.

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7. A shortened statutory period for response to this action is set to expire three

month(s) from the date of this letter. Failure to respond within the period for response

will cause the application to become abandoned. 35 U.S.C. 133

Any inquiry concerning this communication or earlier communications from the

examiner should be directed to Russell Kobert whose telephone number is (571) 272-

1963. The Examiner's Supervisor, Nestor R. Ramirez, can be reached at (571) 272-

2034. For an automated menu of Tech Center 2800 phone numbers call (571) 272-

2800.

Russell M. Kobert Patent Examiner

Group Art Unit 2829

December 5, 2005

VINH NGUYEN
PRIMARY EXAMINER

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12/08/05